Investigation of The Dielectric Properties Of (Cu, Tl) 1234 Added with Graphene

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Abstract
Superconducting samples of type (Cu0.5Tl0.5)-1234 were prepared at normal pressure via one step of conventional solid state reaction technique, and added with x wt.% of graphene (0≤x≤0.1). X-ray powder diffraction (XRD) shows that the addition of graphene does not alter the tetragonal structure and the lattice parameters of the samples. Fourier Transform Infrared (FTIR) measurements indicate the non-uniform distribution of graphene inside the (Cu0.5Tl0.5)-1234 phase. While the Scanning Electron Microscope (SEM) images reveal the increase of the inter-grain connectivity. The superconducting transition temperature Tc, obtained from Ac magnetic susceptibility measurements, shows an enhancement up to x=0.04 Wt. %, followed by a deterioration for x >0.04. The frequency dependence of the dielectric properties of the samples was experimentally investigated at different temperatures (110 K ≤ T ≤ 260 K). The real and imaginary parts (ε' and ε'') of dielectric constant increase up to x=0.1. The study of ε' and ε'', the dielectric loss (tan δ) and the ac-conductivity (σac) have shown that the variation of frequency, temperature and addition of graphene allows the tuning of these parameters for various applications.

Keywords: (Cu0.5Tl0.5)-1234, graphene, FTIR, Dielectric measurements

1. Introduction

The high temperature superconductor (Cu0.5Tl0.5) Ba₂Ca₃Cu₄O₁₂₋δ (Cu,Tl) 1234 is a promising candidate for various practical applications including superconducting electromagnets used in fusion reactors and focusing magnets used in particle accelerators [1]. It has a high Tc, can be prepared under normal pressure, a low superconducting anisotropy (γ=1.6), a long coherence length along c-axis (ξc=1 nm) and a small penetration depth (λc=220 nm) with a high Jc [2]. The effect of nanosized additions on MgO nanoparticles on (Cu,Tl) 1234 has been investigated by many researchers [3-5] and all results have shown that the addition of nanoparticles in a suitable amount improves the structure and superconducting parameters. Awad investigated the effect of MgO nanoparticles on the (Cu0.25Tl0.75)-1234 superconducting phase [6]. Both electrical and mechanical properties including critical current density, superconducting transition temperature and Vickers microhardness were enhanced up to x=0.06 wt.%. The effect of the addition of graphene to HTSCS is still a novel research topic. Sudesh et al.,[7] explored the effect of addition of graphene on superconducting properties of MgB2. The critical current density, upper critical field and irreversibility field were all enhanced with graphene addition. Wei et al. [8] studied the effect of graphene addition on ac Susceptibility and Superconducting Properties of YBa₂Cu₄O₇₋δ. A noticeable enhancement in Jc and grains coupling with the addition of graphene was observed. The effect of graphene addition on (Tl₀.₅Sc₀.₅)Sr₂Ca₂Cu₇O₁₄₋δ superconductor was also examined [9].The superconducting transition temperature decreased with the increase in amount of added graphene, while the critical current density was enhanced for low addition and deteriorated for higher additions of graphene. The investigation of the dielectric properties of high temperature superconductors can provide important parameters for the design of many electronics applications. In general, materials of high dielectric constant are of important applications in memory devices and supercapacitors [10].

Furthermore, the dielectric constants present an evidence about the binding forces that links the mobile carriers between the conducting planes, their interfaces and the charge reservoir layer in high superconducting transition temperature cuprates. Inspite of being extensively characterized, there is still a lack of information concerning the dielectric properties of cuprates. Several factors affect the conduction mechanisms of electronic devices. These factors depend on temperature, frequency, surface charges, manufacture process, space charge effects caused by...
oxygen ions, and doping contents. Hence, the dielectric properties do not maintain the same values at different frequencies and temperatures. As a result, the investigation of the dielectric properties and ac conductivity for different ranges of frequency and temperature is significant. Muntaz et al. [11] studied the dielectric properties of $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2(\mathrm{Ca}_2,\mathrm{Mg}_x)\mathrm{(Cu}_9\mathrm{Zn}_{12-x}\mathrm{O}_{10-\delta})$ and $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$ superconductors. The dielectric constants were found to be intensely influenced by the applied ac-field frequency. Furthermore, Awad [12] found that normal dielectric constant for $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_2\mathrm{Cd}_x\mathrm{Cu}_4\mathrm{O}_{10-\delta}$ was strongly dependent on Cd content and correlated with the normal electrical resistivity results. Younes et al.[13] investigated the dielectric properties of $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{Zn}_x\mathrm{O}_{12-\delta}$ ($y = 0, 3$). The Zn-doped samples showed a decrease in the dielectric loss factor. This loss was attributed to the polarization arising from separation of charges between the $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$ charge reservoir layer and mobile carriers in the conducting $\mathrm{Cu}_2\mathrm{Zn}_2\mathrm{O}_7$ planes. Furthermore, Mohammed N.H [14] explored the effect of nano sized MgO addition on $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$ superconducting Phase. $\varepsilon'$ was found to be frequency and temperature dependent for all amounts of MgO addition. $\varepsilon''$ and $\tan\delta$ showed a dispersion toward lower frequencies with the decrease of operating temperature. Muntaz et al. [15] investigated the effect of NiFe$_2$O$_4$ nanoparticles on dielectric properties of $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$ superconducting phase. The dielectric properties were highly influenced by the temperature and the amount of added NiFe$_2$O$_4$. Khan et al [16] investigated Dielectric response of $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_3\mathrm{M}_x\mathrm{O}_{10-\delta}$ ($M = \mathrm{Cd}, \mathrm{Zn}, \mathrm{Ni}; x=0, 1.5$) Superconductors in the low frequency region. Samples doped with Cd have shown a maximum suppression. This report studies the effect of graphene addition on the structure, ac magnetic susceptibility as well as the dielectric properties of $(\mathrm{Cu},\mathrm{Tl})1234$ superconducting phase. The frequency dependence of the dielectric constants $\varepsilon'$, $\varepsilon''$, $\tan\delta$ and $\sigma_{ac}$ were measured at a temperature range 110 K $\leq T \leq$ 260 K.

2. Methods

2.1 Sample Preparation

Superconducting samples $(\mathrm{CH})_x / (\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta})$, with different addition levels $0.0 \leq x \leq 0.1$ wt. % were prepared by the conventional one-step solid-state reaction technique. The oxides $\mathrm{Tl}_2\mathrm{O}_3$, $\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$, CuO, $\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta}$, and $\mathrm{CH}_n$ powders, with high purity $\geq 99.9 \%$, were weighted in appropriate ratios. They were mixed and well crushed using agate mortar, then sifted using 60 μm sieve to improve the homogeneity of the mixture. The sifted powder was pressed in a disc of dimensions (diameter 1.6 cm and thickness 1.5 mm). The pellets were wrapped carefully in silver foils and placed in sealed quartz tubes to reduce thallium evaporation during the heating process. Furthermore, the tubes were fired in the box furnace at two different rates (4˚C/min to 710 ˚C, 2˚C/min from 710 ˚C to 850 ˚C) then, held at this temperature for 4 hours after which they were cooled down to room temperature at a rate 6 ˚C/min[14].

2.2 Characterization-Dielectric Measurements

The prepared samples were characterized by X-ray powder diffraction (XRD) using the Bruker D8 advance powder diffractometer with Cu-Kα radiation ($\lambda = 1.54056$ Å) in the range $5^\circ \leq 2\theta \leq 70^\circ$. The JEOL JSM-5300 scanning electron microscope was used to examine the microstructure morphology of the samples. Fourier transform infrared spectroscopy analysis was done by FTIR 8400S Shimadzu between 400−700 cm$^{-1}$ wavenumber ranges. The ac magnetic susceptibilities were measured using a quantum design PPMS system equipped with a 9-Tesla superconducting magnet at a temperature range from 25 to 135K all runs at a fixed frequency of 1 KHz. The dielectric properties of the prepared samples were measured at different ranges of frequency and temperature using HIOKI 3532- 50 LCR Hi-tester. The low temperature dielectric measurements were done using liquid nitrogen. By measuring the capacitance and dielectric loss tangent ($\tan\delta$) and the dimension of the sample; the dielectric constants ($\varepsilon'$and $\varepsilon''$) and ac conductivity ($\sigma_{ac}$) were determined using the following expressions [15]

\[
\varepsilon' = \frac{Cd}{\varepsilon_0A'}, \tag{1}
\]

\[
\varepsilon'' = \varepsilon'. \tan\delta, \tag{2}
\]

\[
\sigma_{ac} = \varepsilon'. \varepsilon_0\omega \tan\delta. \tag{3}
\]

Where $\varepsilon_0$ is permittivity of free space, A is the area of electrode, d is the sample thickness, $\omega=2\pi f$ is the angular frequency of applied field.

3. Results

Figure 1 shows the XRD pattern of $(\mathrm{CH})_x / (\mathrm{Cu}_5\mathrm{Tl}_3\mathrm{Ba}_2\mathrm{Ca}_3\mathrm{Cu}_4\mathrm{O}_{12-\delta})$, with $0.0 \leq x \leq 0.1$ wt. %. Most of the diffraction peaks belong to tetragonal structure of $(\mathrm{Cu},\mathrm{Tl})$-1234 phase with a space group P4/mmm. The most intense peak appeared at $2\theta=31.92^\circ$ for pure sample ($x = 0.00$ wt.%) and altered in some samples to $2\theta = 33.2^\circ$. 

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The Lattice parameters $a$ and $c$ for tetragonal structure are calculated and listed in Table 1. The relative volume fractions of (Cu,Tl)-1234, BaCuO$_2$ and (Cu$_{0.5}$Tl$_{0.5}$)-1223 phases are determined by comparing all the peak intensities [17], and are listed in Table 1. The relative volume fraction of (Cu,Tl)-1234 increases up to $x = 0.04$ wt.$\%$, then it decreases with further increases in $x$.

![XRD patterns](image)

**Figure 1.** XRD patterns for ((CH)$_n$)$_x$/(Cu$_{0.5}$Tl$_{0.5}$)Ba$_2$Ca$_3$Cu$_4$O$_{12-\delta}$ with 0.00 ≤ $x$ ≤ 0.10 wt. %

**Table 1.** Variation of the, volume fraction, $T_c$, average grain size, lattice parameters, and frequency exponent (s) for ((CH)$_n$)$_x$/(Cu$_{0.5}$Tl$_{0.5}$)Ba$_2$Ca$_3$Cu$_4$O$_{12-\delta}$ with 0.00 ≤ $x$ ≤ 0.10 wt. %.

<table>
<thead>
<tr>
<th>$x$</th>
<th>Volume fraction (%)</th>
<th>$T_c$ (K)</th>
<th>Average grain size (μm)</th>
<th>$a$ (Å)</th>
<th>$c$ (Å)</th>
<th>s</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.00</td>
<td>90.66</td>
<td>8.63</td>
<td>0.71</td>
<td>108</td>
<td>1.9</td>
<td>3.868</td>
</tr>
<tr>
<td>0.02</td>
<td>90.68</td>
<td>8.26</td>
<td>1.06</td>
<td>113</td>
<td>2.2</td>
<td>3.849</td>
</tr>
</tbody>
</table>
Figures 2(a), (b), (c) and (d) represent the SEM images of graphene added to (Cu0.5Tl0.5)-1234 superconductor phase with x = 0.00, 0.04, 0.08 and 0.10 wt.%, respectively. Fig 2(a) shows small rectangular-shape plates corresponding to the formation of (Cu,Tl)-1234 phase. The formation of rectangular grains was improved with graphene addition for x=0.04 wt.%. For higher additions of graphene the rectangular shapes disappear and the formation of spherical non uniform shapes is observable. The values of the average grain size are listed in table 1.

<table>
<thead>
<tr>
<th>x</th>
<th>Grain Size (μm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.00</td>
<td>2.48</td>
</tr>
<tr>
<td>0.04</td>
<td>1.23</td>
</tr>
<tr>
<td>0.08</td>
<td>7.28</td>
</tr>
<tr>
<td>0.10</td>
<td>10.63</td>
</tr>
</tbody>
</table>

Figure 3 shows the real part of the ac magnetic susceptibility $\chi'$ versus temperature for $((CH)_n)/(Cu_{0.5}Tl_{0.5})Ba_2Ca_2Cu_3O_{12-δ}$ with different additions of graphene at $H = 3$ Oe. The superconducting transition temperature $T_c$ is the temperature at which $\chi'$ changes its sign from a positive to a negative sign. The values of $T_c$ are listed in table 1 and are plotted in the inset of figure 3.
The FTIR absorption spectra of \(((\text{CH})_n)x/(\text{Cu}_{0.5}\text{Tl}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\) (0.0 \leq x \leq 0.1 \text{ wt. %}) in the range from 400 to 700 cm\(^{-1}\) are shown in figure 4. The bands in the range 400-540 cm\(^{-1}\), 541-600 cm\(^{-1}\) and 670-700 cm\(^{-1}\) correspond to the apical oxygen atoms, CuO\(_2\) planner oxygen atoms and O\(_{\delta}\) atoms in the charge reservoir layer, respectively.

Figure 5 shows the frequency dependence of \(\varepsilon'\) at different temperatures for \((\text{Cu}_{0.5}\text{Tl}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\). The general behavior of \(\varepsilon'\) displays a fast decrease with frequency for all temperatures. The variation of \(\varepsilon'\) with frequency for \(((\text{CH})_n)x/(\text{Cu}_{0.5}\text{Tl}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\) (0.00 \text{ wt. %} \leq x \leq 0.10 \text{ wt. %}) at T=110K is shown in the inset of Figure 5. \(\varepsilon'\) shows an increase with \(x\), mostly significant for the sample with \(x=0.1\ \text{wt.\%}\) at which it recorded its highest value (9.5 \(\times 10^6\)).

The complex dielectric constant \((\varepsilon^*=\varepsilon'+j\varepsilon'')\) originates from four different polarizations which are strongly dependent on the frequency range. In the low frequency range (10\(^3\) Hz), the space charge or interfacial polarization arises. In the frequency range 10\(^3\) to 10\(^6\) Hz the dipolar polarization occurs. The atomic and ionic polarizations take place at frequencies ranging from 10\(^{10}\) to 10\(^{13}\) Hz. At high frequency of 10\(^{15}\) Hz, the electronic polarization is observed [18]. The dipolar and space charge polarization play the main role in our measurements.

The imaginary part of the dielectric constant \(\varepsilon''\), reflects the amount of energy the attenuated of energy at defect sites, grain boundaries and localized charge densities when the samples are exposed to an external electric field. The frequency dependence of \(\varepsilon'\) at different temperatures for \((\text{Cu}_{0.5}\text{Tl}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\) is shown in figure 6. The (Cu-Tl) 1234 phase exhibit the dielectric dispersion, in low frequency range, where \(\varepsilon''\) decreases as the frequency increases with no observable effect of temperature. It is shown in the inset of Figure 6, that \(\varepsilon''\) shows a similar behavior for all values of \(x\) at T=110K.
Figure 4. The FTIR absorption spectra of \(((\text{CH})_x)_{(\text{Cu}_{0.5}\text{Tl}_{0.5})}\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}} \) with \(0.00 \leq x \leq 0.10\) wt. %
Dielectric loss or tan δ is usually referred to as dissipation factor and it is significant to understand the mechanisms of dielectric relaxation and ac conduction. The dependence of dielectric loss on the frequency at different temperatures for (Cu_{0.5}Tl_{0.5})Ba_2Ca_3Cu_4O_{12.8} is shown in figure 7. It shows that at low frequency the value of tanδ slightly increased with increasing of temperature. The inset of figure 7 shows the frequency dependence of tanδ at T=110 K for ((CH)_n)/(Cu_{0.5}Tl_{0.5})Ba_2Ca_3Cu_4O_{12.8} with 0.00 ≤ x ≤ 0.10 wt. %.

At low frequency tanδ decreases for addition of graphene and attains its lowest value for x = 0.04 wt % and then it increases for x > 0.04 wt%.
Figure 7. Frequency dependence of tanδ at different temperatures \((\text{Cu}_{0.5}\text{Ti}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\). The inset represents the Frequency dependence of tanδ at \(T=110\) K for \(((\text{CH})_n)_{x}/(\text{Cu}_{0.5}\text{Ti}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\) with \(0.00 \leq x \leq 0.10\) wt. %.

The variations of \(\sigma_{ac}\) with frequency for pure sample at different temperatures (Fig.8) and its variation with frequency for different \(x\) at \(T = 110K\) (inset of figure 8) follow a similar behavior to that of \(\varepsilon'\) and \(\varepsilon''\). The values of \(\sigma_{ac}\) is not temperature dependent, however it shows an increase with \(x\). The increase trend in \(\sigma_{ac}\) at fixed temperature of 110K with the addition of graphene is also observed.

Figure 8. Frequency dependence of \(\sigma_{ac}\) at different temperatures \((\text{Cu}_{0.5}\text{Ti}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\). The inset represents the Frequency dependence of \(\sigma_{ac}\) at \(T=110\) K for \(((\text{CH})_n)_{x}/(\text{Cu}_{0.5}\text{Ti}_{0.5})\text{Ba}_2\text{Ca}_3\text{Cu}_4\text{O}_{12-\delta}\) with \(0.00 \leq x \leq 0.10\) wt. %.
Figures 9. the plot of $\ln \sigma_{ac}$ versus $\ln \omega$ for for $(\text{CH})_n/(\text{Cu}_{0.5}\text{Tl}_{0.5})\text{Ba}_2\text{Cu}_3\text{Cu}_4\text{O}_{12-\delta}$ at $t=110$ K for different $x$

4. Discussion

The shift in the most intense peak in the XRD graphs is probably due to the increase of BaCuO$_2$, which depend on the vapor pressure inside the preparation tube [17]. Small amounts of BaCuO$_2$ and (Cu$_{0.5}$,Tl$_{0.5}$)-1223 phases appears in the XRD pattern. The lattice parameters have shown unsystematic variation with the addition of graphene. Thus, the graphene addition may occupy the vioids between the superconductor grains without entering inside (CuTl)-1234 crystal structure. The suppression in the volume fraction means that high concentrations of graphene addition retards the formation of (Cu,Tl)-1234. This might be attributed to the change in viscosity and homogeneity of the of the transient liquid formed at the reaction temperature.

For low concentration percentages ($0.02 \leq x \leq 0.04$), addition of graphene improves the formation of rectangular grains as shown in Fig. 2(b) where the optimal is at $x = 0.04$ wt.%. This was confirmed by the improvement of volume fraction as discussed before in XRD results. The size of the grains is not highly affected but the increase in the connectivity and reduction of pores is recognizable. This is due to the presence of graphene at grain boundaries and its occupation of the void regions, which causes an improvement of the inter-grain connectivity of superconductor matrix. It should be noted that graphene was prepared separately and then it was added to (CuTl)-1234 superconductor matrix, thus the place where these particles can reside is only the superconductor grain surfaces and/or between grains. For high concentration of graphene addition, the rectangular shapes increase in size up to $x=0.08$ wt.%% as shown in figure 2c and then it disappears gradually up to $x = 0.10$ wt.%. This can be attributed to the decrease in the volume fraction of the main phase and the formation of secondary phases such as (Cu,Tl)-1223.

The values of $T_c$ plotted in the inset of figure 3, increase from 108K for the pure sample to 116K for the sample with $x = 0.04$ wt.% with an enhancement rate of 7.4%. For $x>0.04$, $T_c$ decreases to attain its minimum value of 95K for $x=0.1$wt. %, with a retardation rate of 12%. The behavior of $T_c$ is compatible with the behavior of the volume fraction of (Cu-Tl)-1234 superconducting phase obtained from XRD measurements. The increase in $T_c$ is a consequence of the improvement of weak links through grain boundaries due to the addition of graphene which fills the pores and consequently increase the electrical contacts between the grains. The suppression of $T_c$ may be attributed to the decrease in the volume fraction of the main phase [19], (Cu, Tl)-1234 phase or the trapping of mobile carriers. Another explanation might be that for high additions, graphene gets agglomerated at grain boundaries increasing their resistance, as being an allotrope of carbon which is known for deterioration of superconductivity. Barik et al. [20], reported that high amounts of nano particles addition enhances the mechanism of cooper pair breaking, this might be a reason for the deterioration of the superconducting properties with high additions of graphene.

Observing the FTIR spectra plotted in figure 4, we observe a small variation in the oxygen modes $O_5$ in the reservoir layer ranges between 668 to 680 cm$^{-1}$. The apical oxygen modes of type Tl-OA-Cu(2), apical oxygen mode of type Cu(1)-OA-Cu(2) and planner oxygen mode Cu(2)-OP-Cu(2) show a disturbance variation in the
position of oxygen modes with few unchangeable peaks. It is believed that the stress and strains induced by the
addition of graphene affect the bond length and hence causes a variation in the position of these modes. However,
these results indicate the non-homogenous distribution of graphene inside the superconducting matrix.

The decrease in the values of $\varepsilon'$ with frequency as shown in figure 5 is attributed to the decrease in the dipolar
polarization contribution due to large inertia of oscillating dipoles; hence the time constant of the applied field is
shorter than the dipolar polarization characteristic time at high frequencies of applied field [11]. In fact, at low
frequency the carriers can follow the frequency of the external applied ac field and at higher frequency the period
becomes very short and hence the carriers cannot follow the field and the response of the sample becomes
insignificant. For high frequencies beyond 1 MHz, the dielectric constant $\varepsilon'$ becomes temperature independent
confirming that $\varepsilon'$ originates from electronic and lattice polarizations on account of their short relaxation time
relative to the time constant of the applied field [10]. On the other hand, $\varepsilon'$ shows a decrease with the increase of
temperature resulting from the decrease in polarizability due to thermal agitation. This result confirms that the
superconducting phase is comprised of strongly coupled carriers [21]. This high value of $\varepsilon'$ for $x=0.1$ at $T=110K$,
as shown in the inset of figure 5 is attributed to the effect of high concentration addition of graphene in the
enhancement of the formation of impurities resulting from secondary phases, and scattering at grain boundaries,
consistent with the smallest value of volume fraction and $T_c$ obtained from XRD and ac susceptibility
measurements respectively for the sample of $x=0.10$ wt.%

The Maxwell–Wagner model [22] in addition to Koop’s phenomenological theory [23] are used to interpret the
dielectric response of our samples. According to these models, a dielectric medium is composed of two parts:
strongly conducting grains with high values of permittivity surrounded by weak grain boundaries with low values
of permittivity. At lower frequencies the grain boundaries show a higher response than electrical conduction grains.
The sample with $x = 0.10$ wt.% recorded the highest value of $\varepsilon''$ probably due to the accumulation of high
concentration of graphene at the grain boundaries.

The behavior of $\tan \delta$ shown in figure 7 and its inset is compatible with the results of SEM and volume fraction
calculations. This behavior correlates with the enhancement of the superconducting properties with the addition of
graphene till a certain concentration ($x = 0.04$ wt %) above which further addition of graphene causes a deterioration of the superconducting properties.

The rise of the values of $\sigma_{ac}$ with the addition of graphene at $T=110K$ as shown in figure 8 is an indication of the
enhancement of the inter-granular links. This is due to the fact that graphene nanoparticles occupy the grain
boundaries and heal up the cracks by filling the pores and voids. The drop of ac conductivity with the increase in
frequency suggests that it arises due to the free carriers [24]. Several superconductors including Bi$_2$Sr$_2$Ca$_2$Cu$_3$O$_y$,
Bi$_2$Sr$_2$CaCu$_2$O$_8$ and YBa$_2$Cu$_3$O$_y$ were reported in literature [25] and [26] to behave similarly in the infra-red
frequency range.

The frequency dependence of $\sigma_{ac}$ is expressed by the relation [27]

$$\sigma_{ac} = Q . \omega^{-s}$$

(4)

where $Q$ is the pre-exponential factor and $s$ is the frequency exponent. If $s < 1$ it indicates the hopping motion is
translational one, while if $s > 1$ then the motion is a localized one. The values of $s$ in equation (4) were extracted
from the slopes of the linear fits of plots of $\ln \sigma_{ac}$ versus $\ln \omega$ at $T=110K$ that are represented in figure 9. All
values of $s$ are greater than 1 ($s > 1$) which indicates that the hopping motion is localized. According to quantum
mechanical tunneling model [28], the frequency exponent $s$ depends on frequency and does not depend on
temperature. The motion of carriers that give rise to ac conductivity does not cause a distortion in the lattice.

5. Conclusions

In this work, ((CH)$_n$)$_x$((Cu$_{0.5}$Tl$_{0.5}$)$_{1-x}$Ba$_2$Ca$_3$Cu$_4$O$_{12-\delta}$ superconducting phase was successfully prepared by
conventional solid-state reaction technique, with 0.0 wt. % ≤ $x$ ≤ 0.1 wt. The lattice parameters had no significant
variation with the addition of graphene while the volume fraction of the superconducting phase as well as the
superconducting transition temperature $T_c$ were enhanced with $x$ up to 0.04 wt. % and then deteriorated with further
increase in $x$. FTIR results indicated that the shift in wave number for each peak is a result of the sticking of the added
graphene on the grain boundaries. The dielectric parameters including $\tan \delta$, $\varepsilon'$, $\varepsilon''$ and $\sigma_{ac}$ have shown a
decrease due to the accumulation of high concentration of graphene on grain boundaries. The behavior of $\tan \delta$ was
related to the effect of addition of graphene in enhancement of the superconducting parameters at low additions
and the deterioration of the superconducting phase at higher addition of graphene. $\sigma_{ac}$ was found to be temperature
independent, but decreases with frequency. The frequency exponent factor $(s)$ was found to be greater than one,
indicating a localized hoping motion of carriers. As a conclusion, the dielectric parameters of
((CH)n)x/(Cu0.5Tl0.5) Ba2Ca3Cu4O12-δ superconducting phase can be tuned by frequency, operating temperatures, and the amount of added graphene.

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